Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/852;732	HUIE, DAVID L.
Examiner	Art Unit
Thjuan P. Knowlin	2642

SEARCHED						
Class	Subclass	Date	Examiner			
379	211.02	2/15/2006	TPK			
379	127.05	2/15/2006	TPK			
379	211.02	2/15/2006	TPK			
379	221.13	2/15/2006	TPK			
		=				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				
	_				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST search terms: originating; switch; initial; address; message; redirection; fraud; isdn	2/15/2006	TPK